

Application/Control No.	Applicant(s)/Patent under Reexamination
10/528,426	MUELLER ET AL.
Examiner	Art Unit
Benny Lee	2817

	SEAR	CHED	
Class	Subclass	Date	Examiner
333	204,219, 208	4/23/2007	BTL
Rsch	above	9/21/2007	BTL
333	230	9/21/2007	BTL
Rsch	above	1/25/2008	BTL
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH	TES I STRATEGY	')
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